Imaging Processing Pipeline for Color Printers & Printing Systems

Session III

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Outline

- Device Modeling
 - Analytical Modeling
 - Empirical Modeling
 - Model Inversion
- Gamut Mapping

Device Modeling

- How does one build a model of a device?
 - Device Classes
- Typical device modeling falls into two categories
 - Analytic Modeling
 - Empirical Modeling

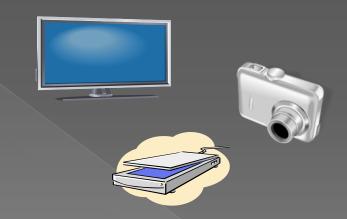
Device Classes

Additive Devices

- Displays
- Scanners
- Digital Cameras

Subtractive Devices

Printers





Common Additive Device Models

Gain-Offset-Gamma (GOG) Model

$$\{R',G',B'\} = Offset_{\{R,G,B\}} + (\{R,G,B\} * Gain_{\{R,G,B\}}) \{R',G,B\} Gamma [X,Y,Z]^T = M \cdot [R',G',B']^T$$

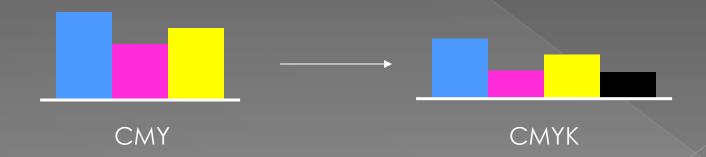
Where M is determined by least squares regression

$$M = (A^{T}A)^{-1}A^{T}B$$
 Linear Model $M = (A^{T}WA)^{-1}A^{T}WB$ Weighted Linear Model

If higher order coefficients are used (R², G², B², RG, RB, GB, etc.) in A, a higher order polynomial model can be used.

Modeling Subtractive Devices

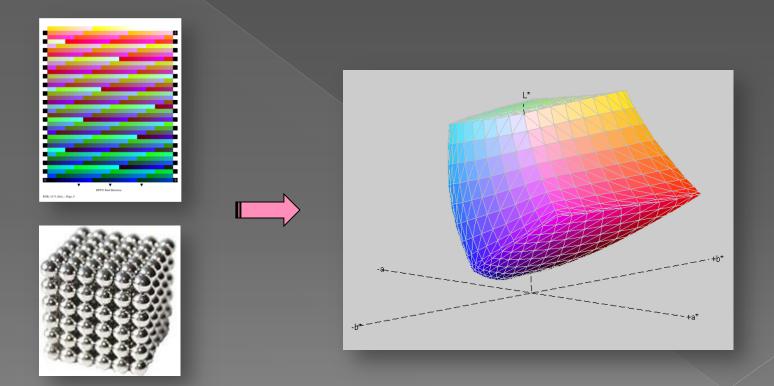
- To address the full range of colors on a CMYK device would need 256⁴ combinations, which is not practical
- Build a CMY to CMYK transform called a color separation



Many color separation schemes exist







3D Device Model

Analytic Subtractive models

Murray-Davies Equation
Yule-Nielsen Modification
Kubelka-Munk
Neugebauer

Many of these systems perform poorly for complex nonlinear models (like printing)

Murray Davies Equation

$$R(\lambda)=(1-a)R_W(\lambda)+aR_S(\lambda)$$
 where a is fractional area coverage (0\le a\le 1)
$$a=rac{(R_W-R_N)}{(R_W-R_S)}$$

Yule Nielsen Modification

$$[R(\lambda)]^{\frac{1}{n}} = (1-a)[R_w(\lambda)]^{\frac{1}{n}} + a[R_s(\lambda)]^{\frac{1}{n}}$$

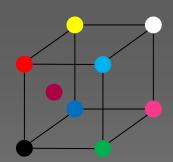
The KM and Y-N equations are very simple, single colorant models that attempt to model halftoned response



Neugebauer Equations

The Spectral Neugebauer model extends to multiple colorants

$$R(\lambda) = \sum_{j=1}^{m} a_{j} R_{j}(\lambda)$$



Where

 $m = 2^n$ colorants

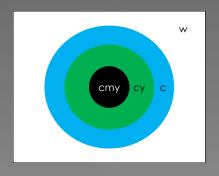
 $R_i(\lambda)$ = Spectral reflectance of Neugebauer primary

 The colorant weighting factors (a_j) are computed based on the halftone printing model used

Dot on Dot

Colorants sorted in order of area coverage

White	$a_1 = 1 - c$
1 color	$a_2 = c - y$
2 color	$a_3 = y - m$
3 color	$a_{4} = m$

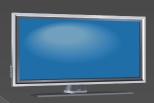


Rotated Screen

Using the Demichel equations, the fractional area coverages are calculated

 $a_1 = (1-c)(1-m)(1-y)$ White $a_2 = c(1-m)(1-y)$ Cyan $a_3 = m(1-c)(1-y)$ Magenta $a_4 = y(1-c)(1-m)$ Yellow $a_5 = my(1-c)$ Red $a_6 = cy(1-m)$ Green $a_7 = cm(1-y)$ Blue Black $a_8 = cmy$







Empirical Device models

Cellular Neugebauer (Hybrid)

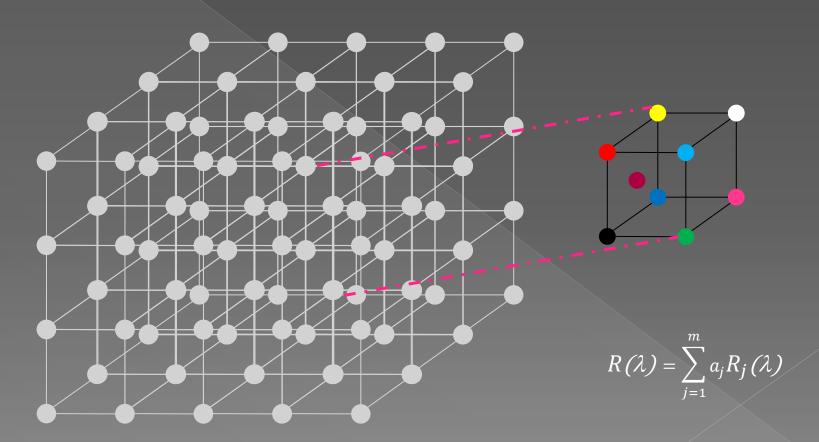
Tetrahedral

Tri-Linear

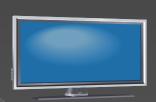
Prism

Pyramid

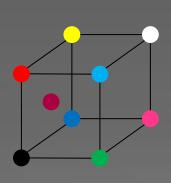
Cellular Neugebauer

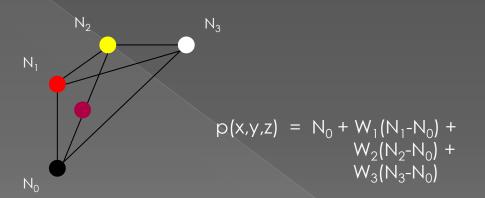






Tetrahedral Interpolation



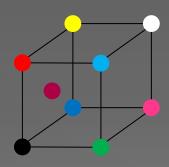


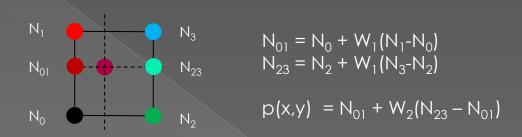
Each interpolation methods has its strengths and weaknesses





Tri-linear Interpolation





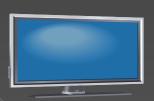
In 2 Dimensions (bi-linear)

Weights W_1 and W_2 are the relative distanced between the nodes Each interpolation methods has its strengths and weaknesses

• Interpolation Summary

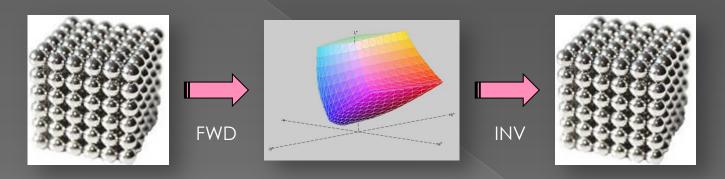
Method	Strengths	Weaknesses
Cellular Neugebauer	Very accurate multi- dimensional model	Complexity grows quickly as # dimensions increases
Tetrahedral	Preserves color balance for neutral axis interpolation	Identifying tetrahedron is computationally expensive
Tri-Linear	Cannot guarantee neutral axis preservation across diagonal	Computationally efficient





Color Table Inversion

One must be able to "round-trip" with a high degree of accuracy

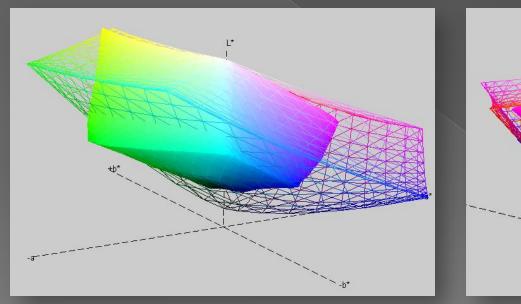


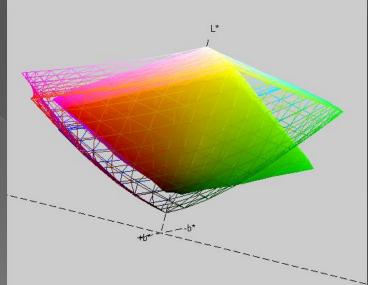
- The process of building the inverse map is non-trivial, with many-to-one mappings possible
- Common methods: "Brute force" tetrahedral inversion. Thin-plate splines

Gamut Mapping

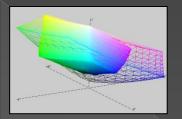
- Attempting to fit the color gamut of one device into another devices gamut
- Color appearance models are used to help preserve appearance attributes
- Different GM algorithms trade the errors in Lightness,
 Chroma and Hue differently
- Overall objective is to render a pleasant reproduction

Comparing Device Gamut's

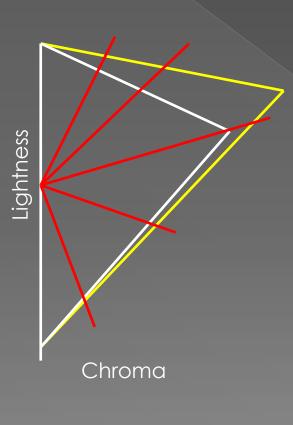




The process of mapping colors from one device to another - Gamut Mapping

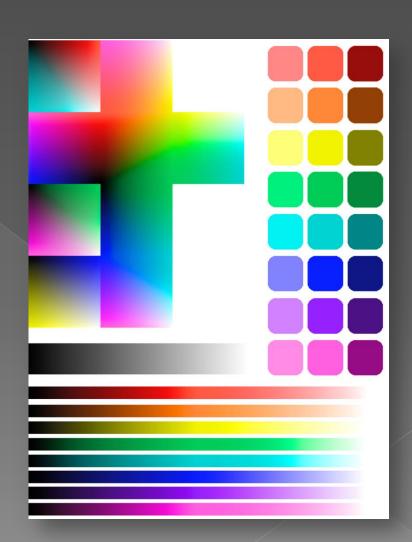


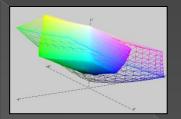
Centroid



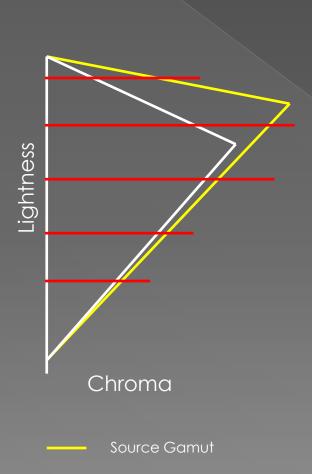
Source Gamut

Destination Gamut



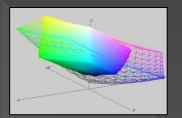


Constant L*

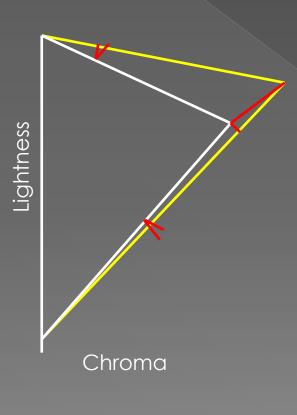


Destination Gamut



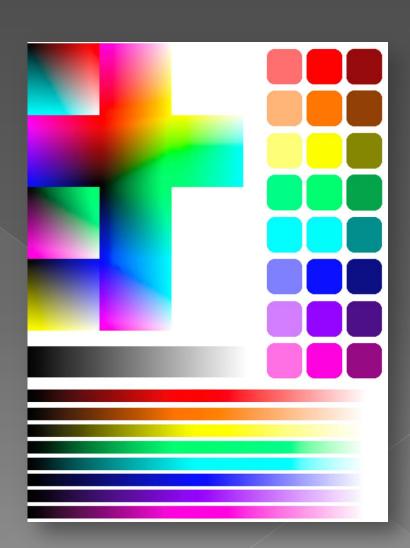


Min DE



Source Gamut

Destination Gamut

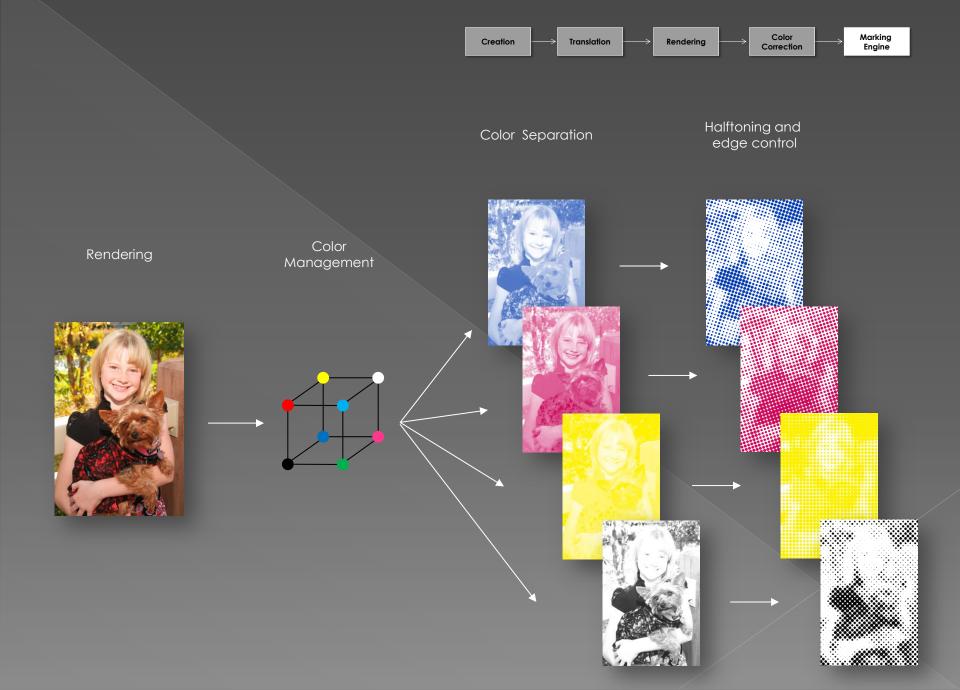


Centroid Constant L* Min DE

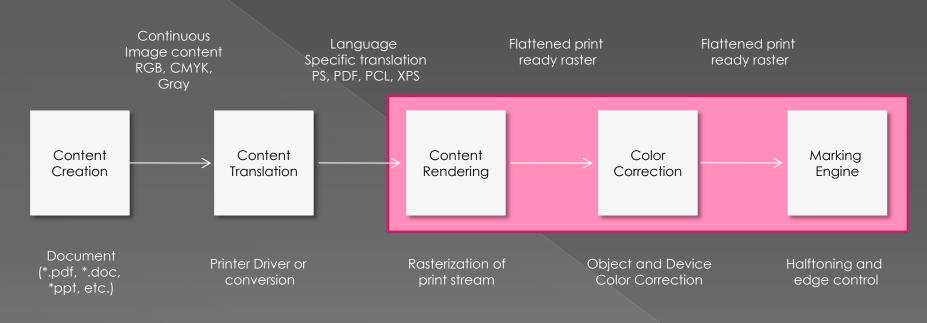








Embedded Systems



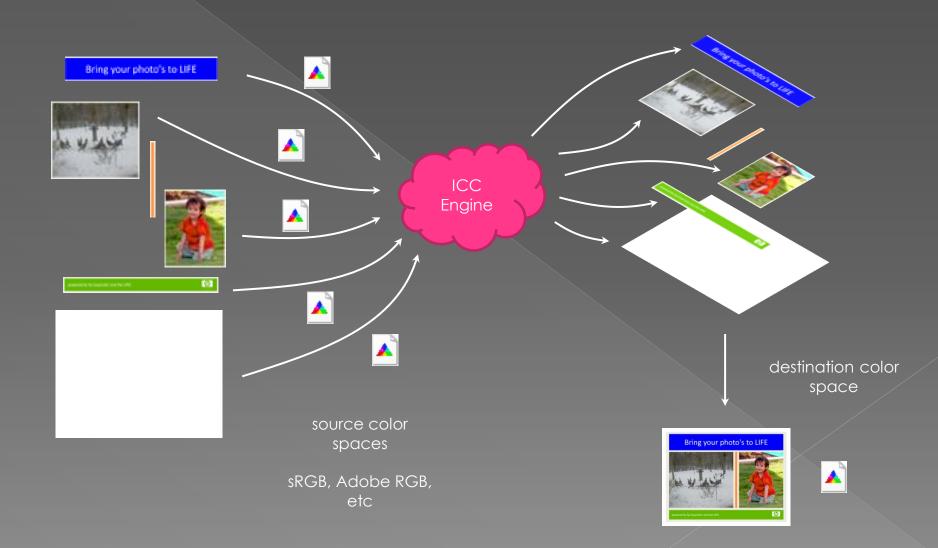




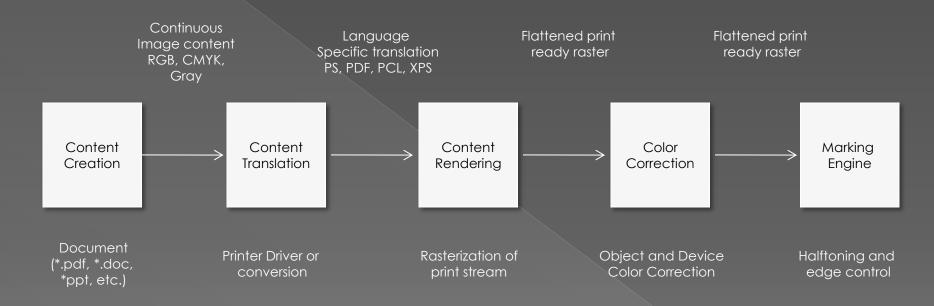
Summary

- End-to-end document imaging workflow
- Content Creation
- Document Translation
- Rendering Stream
- Color Management
- Device Modeling
- Gamut Mapping





Summary







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